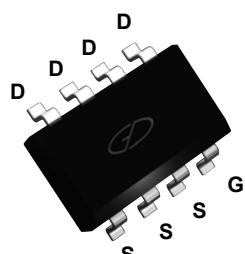
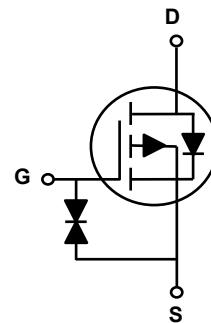


Main Product Characteristics

V_{DSS}	-30 V
$R_{DS(ON)}$	10.6 m Ω (typ.)
I_D	-12A



SOP-8



Schematic Diagram

Features and Benefits

- Advanced trench MOSFET process technology
- Ideal for PWM, load switching and general purpose applications
- Ultra low on-resistance with low gate charge
- Fast switching and reverse body recovery
- 150°C operating temperature



Description

The SSF3611E utilizes the latest techniques to achieve high cell density and low on-resistance. These features make this device extremely efficient and reliable for use in high efficiency switch mode power supply and a wide variety of other applications.

Absolute Maximum Rating

Symbol	Parameter	Max.	Unit
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$ ①	-12	A
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$ ①	-7.4	
I_{DM}	Pulsed Drain Current②	-48	
$P_D @ T_C = 25^\circ C$	Power Dissipation③	2	W
V_{DS}	Drain-Source Voltage	-30	V
V_{GS}	Gate-to-Source Voltage	± 20	V
T_J, T_{STG}	Operating Junction and Storage Temperature Range	-55 to +150	°C

Thermal Resistance

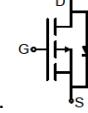
Symbol	Characteristics	Typ.	Max.	Unit
$R_{\theta JA}$	Junction-to-Ambient ($t \leq 10S$) ④	—	62.5	°C/W

Electrical Characteristics ($T_A=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	-30	—	—	V	$V_{GS} = 0\text{V}, I_D = 250\mu\text{A}$
$R_{DS(\text{ON})}$	Static Drain-to-Source On-resistance	—	10.6	13	$\text{m}\Omega$	$V_{GS} = -10.0\text{V}, I_D = -10.0\text{A}$
		—	14.1	16		$V_{GS} = -4.50\text{V}, I_D = -7.50\text{A}$
$V_{GS(\text{th})}$	Gate threshold Voltage	-1	—	-2	V	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$
I_{DSS}	Drain-to-Source Leakage Current	—	—	-1	μA	$V_{DS} = -30\text{V}, V_{GS} = 0\text{V}$
I_{GSS}	Gate-to-Source Forward Leakage	—	—	10	μA	$V_{GS} = 20\text{V}$
		—	—	-10		$V_{GS} = -20\text{V}$
Q_g	Total Gate Charge	—	55	—	nC	$I_D = -10\text{A},$ $V_{DS} = -25\text{V},$ $V_{GS} = -10\text{V}$
Q_{gs}	Gate-to-Source Charge	—	3.5	—		
Q_{gd}	Gate-to-Drain("Miller") Charge	—	18	—		
$t_{d(\text{on})}$	Turn-on Delay Time	—	8.0	—	nS	$V_{GS} = -10\text{V}, V_{DS} = -15\text{V},$ $R_L = 15\Omega,$ $R_{\text{GEN}} = 3\Omega$
t_r	Rise Time	—	5.8	—		
$t_{d(\text{off})}$	Turn-Off Delay Time	—	56	—		
t_f	Fall Time	—	38	—		
C_{iss}	Input Capacitance	—	3224	—	pF	$V_{GS} = 0\text{V}$
C_{oss}	Output Capacitance	—	459	—		$V_{DS} = -15\text{V}$
C_{rss}	Reverse Transfer Capacitance	—	425	—		$f = 1\text{MHz}$

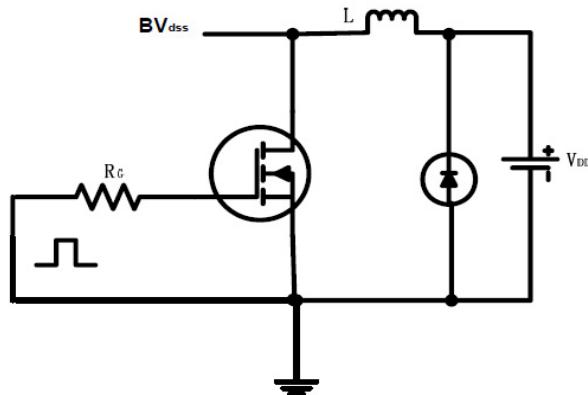
Source-Drain Ratings and Characteristics

Symbol	Parameter	Min.	Typ.	Max.	Unit	Conditions
I_s	Continuous Source Current (Body Diode)	—	—	-12	A	MOSFET symbol showing the integral reverse p-n junction diode.
I_{SM}	Pulsed Source Current (Body Diode)	—	—	-48	A	
V_{SD}	Diode Forward Voltage	—	-0.73	-1.2	V	$I_S = -2.1\text{A}, V_{GS} = 0\text{V}$
t_{rr}	Reverse Recovery Time	—	16	—	nS	$T_J = 25^\circ\text{C}, I_F = -10\text{A}, dI/dt = 100\text{A}/\mu\text{s}$
Q_{rr}	Reverse Recovery Charge	—	5.9	—	uC	

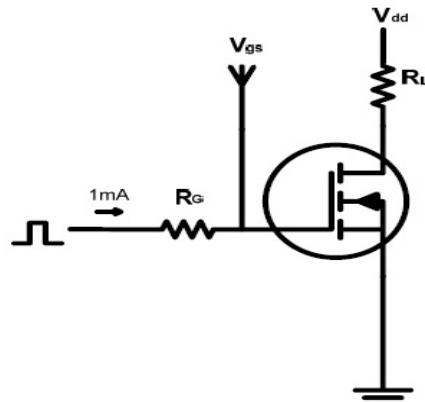


Test Circuits and Waveforms

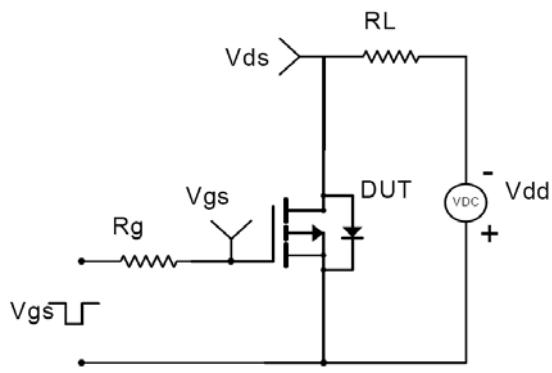
EAS test circuits:



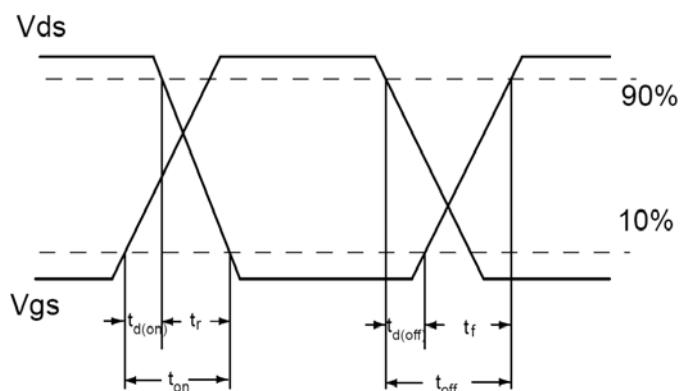
Gate charge test circuit:



Switch time test circuit:



Switching Waveforms

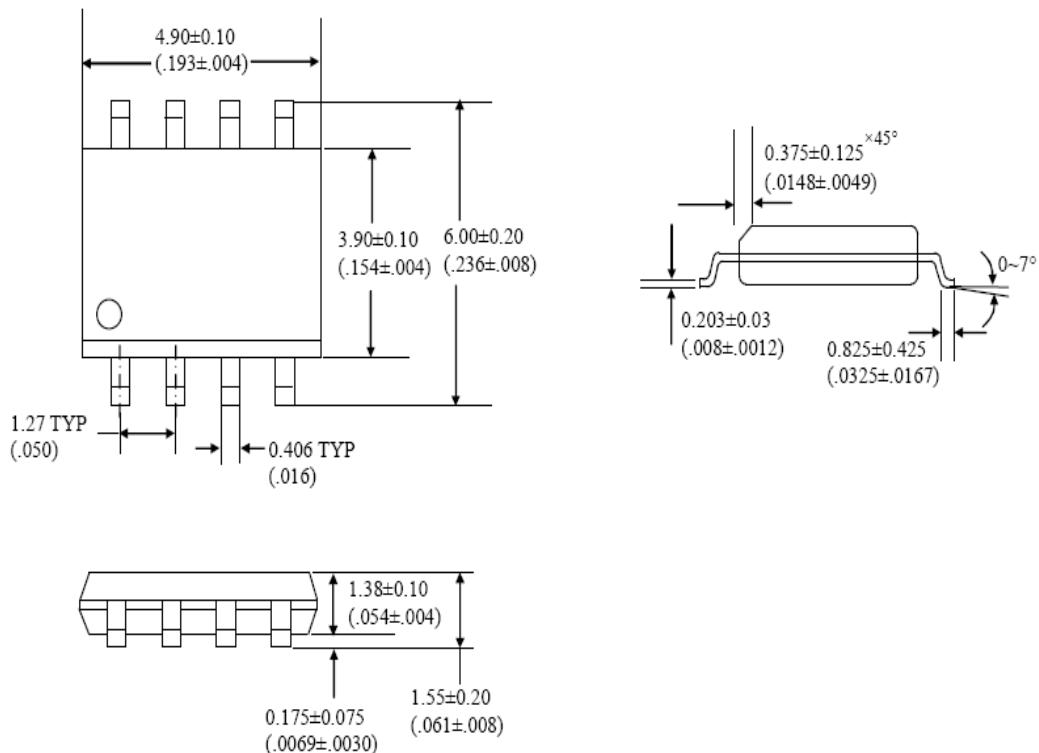


Notes:

- ① The maximum current rating is limited by bond-wires.
- ② Repetitive rating; pulse width limited by max. junction temperature.
- ③ The power dissipation P_D is based on max. junction temperature, using junction-to-ambient thermal resistance.
- ④ The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^\circ C$

Mechanical Data

SOP-8 PACKAGE OUTLINE DIMENSION



Symbol	Dimension In Millimeters		Dimension In Inches	
	Min	Max	Min	Max
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.004	0.010
A2	1.280	1.480	0.050	0.058
b	0.406		0.016	
c	0.173	0.233	0.007	0.009
D	4.800	5.000	0.189	0.197
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.27TYP		0.050TYP	
L	0.400	1.250	0.016	0.050

Ordering and Marking Information

Device Marking: SSF3611E

Package (Available)

SOP-8

Operating Temperature Range

C : -55°C to +150 °C

Devices per Unit

Package Type	Units/ Tape	Tapes/Inner Box	Units/Inner Box	Inner Boxes/Carton Box	Units/Carton Box
SOP-8	2500	2	5000	8	40000

Reliability Test Program

Test Item	Conditions	Duration	Sample Size
High Temperature Reverse Bias(HTRB)	$T_J=125^{\circ}\text{C}$ or 150°C @ 80% of Max $V_{DSS}/V_{CES}/VR$	168 hours 500 hours 1000 hours	3 lots x 77 devices
High Temperature Gate Bias(HTGB)	$T_J=125^{\circ}\text{C}$ or 150°C @ 100% of Max V_{GSS}	168 hours 500 hours 1000 hours	3 lots x 77 devices